## Notice of References Cited Application/Control No. 09/668,604 Examiner Binh X Tran Applicant(s)/Patent Under Reexamination QIAO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,448,140	09-2002	Liaw, Jhon-Jhy	438/279
	В	US-6,406,987	06-2002	Huang, Jenn Ming	438/595
	С	US-6,255,700	07-2001	Yoshida et al.	257/380
	D	US-6,136,682	10-2000	Hegde et al.	438/622
	Ε	US-5,840,624	11-1998	Jang et al.	438/624
	F	US-5,604,374	02-1997	Inou et al.	257/593
	G	US-			
	Н	US-			
	1	US-			
	J	US-	,		
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р			4.1		
	α					
	R					
	S					
	Т	·				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.